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PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re A	oplication of:)	
-	. •	:	Examiner: H. Tran
KEIICH	HIRO ISHIHARA)	
		:	Group Art Unit: 2861
Applica	ation No.: 10/763,231)	
		:	
Filed:	January 26, 2004)	
		:	
For:	MULTI-BEAM SCANNING)	
	APPARATUS	:	September 29, 2006

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

Pursuant to 37 C.F.R. § 1.56, Applicant respectfully directs the Examiner's attention to the documents listed below and on the enclosed Form PTO-1449. A copy of each non-U.S. patent document so listed is enclosed. Copies of U.S. patent documents are not enclosed, pursuant to 37 C.F.R. § 1.98(a) as revised September, 2004 and pursuant to the waiver published at 1287 OG 163 (October, 2004).

Japan 4-353816 Japan 6-233074 Japan 7-281112 Japan 9-187990 Japan 2001-51216 Japan 2001-201704 Japan 2001-215426 Japan 2002-67382 These documents were cited during prosecution of a Japanese patent application corresponding to the above U.S. application. A copy of a Notification of Reason for Refusal from the Japanese Patent Office, which is dated July 25, 2006, together with an English language translation thereof, is enclosed. In view of this date, it is hereby certified under 37 C.F.R. § 1.97(e) that each document in this Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Statement.

The concise explanation of relevance for the non-English documents cited above is provided in the English translation of the Japanese Notification and by the English language abstracts included with the cited art.

In addition, it is believed that U.S. Patent 6,429,956 is an English language counterpart of Japan 2001-201704, and that U.S. Patent 6,483,529 is an English language counterpart of Japan 2001-215426; those patents are also listed on the attached form PTO-1449.

The Examiner is urged to study this information in its entirety and to form an independent determination of the materiality of the information to the claimed invention. Additionally, the Examiner is requested to indicate that this information has been considered by initialling the appropriate portion of Form PTO-1449.

Applicant's undersigned attorney may be reached in our Costa Mesa,

California office at (714) 540-8700. All correspondence should continue to be directed to our below-listed address.

Respectfully submitted,

Attorney for Applicant Michael K. O'Neill Registration No. 32,622

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FORM PTO 1449 (modified)			ATTY DOCKET NO. APPLICATION NO. 03500.017853		APPLICATION NO.	10/763,231				
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OPPORT IN THE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			APPLICANT							
LIST OF REFERENCES CITED BY APPLICANT(S)			KEIICHIRO ISHIHARA							
			FILING DATE			GROUP				
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OCT 0 2 2000 FILING DATE January 26, 2004 U.S. PATENT DOCUMENTS PARENT DOCUMENTS FILING DATE U.S. PATENT DOCUMENTS FILING DATE F										
· *EXAMINER DOCUMENT							FILING DATE			
INITIAL	NUMBER	DATE	NAME		CLASS	SUBCLASS	IF APPROPRIATE			
	6,429,956	8/6/02	Itabashi		359	204				
	6,483,529	11/19/02	lto, et al		347	245	_			
										
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	DOCUMENT NUMBER	DATE	COUNTRY		CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT			
	4-353816	12/8/92	Japan				Abstract			
	6-233074	8/19/94	Japan				Abstract			
	7-281112	10/27/95	Japan				Abstract			
	9-187990	7/22/97	Japan				Abstract			
	2001-51216	2/23/01	Japan				Abstract			
	2001-201704	7/27/01	Japan				Abstract			
	2001-215426	8/10/01	Japan				Abstract			
	2002-67382	3/5/02	Japan				Abstract			
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)										
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EXAMINER DATE CONSIDERED										

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1